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Evidence of a magnetic transition in atomically
thin Cr₂TiC₂T_x MXene†

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Two-dimensional (2D) transition metal carbides and nitrides known
as MXenes have shown attractive functionalities such as high
electronic conductivity, a wide range of optical properties, versatile
transition metal and surface chemistry, and solution processability.
Although extensively studied computationally, the magnetic prop-
erties of this large family of 2D materials await experimental
exploration. 2D magnetic materials have recently attracted signifi-
cant interest as model systems to understand low-dimensional
magnetism and for potential spintronic applications. Here, we
report on synthesis of Cr₂TiC₂T_x MXene and a detailed study of its
magnetic as well as electronic properties. Using a combination of
magnetometry, synchrotron X-ray linear dichroism, and field- and
angular-dependent magnetoresistance measurements, we find
clear evidence of a magnetic transition in Cr₂TiC₂T_x at approxi-
mately 30 K, which is not present in its bulk layered carbide
counterpart (Cr₂TiAlC₂ MAX phase). This work presents the first
experimental evidence of a magnetic transition in a MXene material
and provides an exciting opportunity to explore magnetism in this
large family of 2D materials.20
New concepts25
MXene is a large and rapidly growing family of 2D transition metal
carbides, carbonitrides, and nitrides with outstanding electronic, optoe-
lectronic, mechanical, and thermal properties. Within less than a decade
after the first MXene, Ti₃C₂T_x, was discovered, more than 30 MXenes with
different compositions have been experimentally synthesized. Given the
large number of transition metals that can be included in their structure,
MXenes have been predicted to form a plethora of 2D magnetic materials.
However, their magnetic properties remain largely unexplored experi-
mentally. In this work, we provide an experimental evidence of a
magnetic transition in Cr₂TiC₂T_x, an ordered double transition metal
carbide MXene, using a combination of magnetometry, spectroscopy, and
magnetotransport measurements. This finding adds a new functionality
to the MXene family and paves the way for further studies of magnetism
in this large family of 2D materials. The desired magnetic properties can
potentially be achieved by manipulation of the transition metal composi-
tions including solid solutions, C/N ratio, surface terminations, and
interlayer magnetic coupling in MXenes. This multi-level control of
magnetic properties is a unique advantage of MXenes compared to
other existing 2D magnets.40
Introduction45
Following the realization of ferromagnetic ordering in mono-
layer CrI₃ and ultrathin Cr₂Ge₂Te₆,^{1,2} there has been a surge in
the discoveries of intrinsic 2D magnetic materials as well as
their applications.^{3–14} However, most 2D magnetic materials
reported to date are produced either by mechanical exfoliation
of van der Waals layered materials or sophisticated epitaxial
growth on specific substrates.^{5,8} In addition, the ultrathin
crystals are generally unstable under ambient conditions, so
the experiments were either done in inert environments or an
additional capping layer was required. This poses a challenge
for both fundamental studies and the development of devices
using the existing 2D magnetic materials.55
Two-dimensional transition metal carbides (MXenes) have
received increasing interest in applications including energy
storage, optoelectronics, plasmonic, and photonics.^{15,16} With
several possible combinations of transition metals, a large† A.J. Drexel Nanomaterials Institute, Drexel University, Philadelphia, PA 19104,
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1 variety of atomic arrangements, and tunable surface chemis-
 2 try, MXenes exhibit a wide range of electronic and optical
 3 properties.¹⁷ Importantly, they can be synthesized *via*
 4 solution-processing in large quantity and are relatively stable
 5 under ambient conditions compared to other 2D magnets.¹⁸
 6 Although MXenes are an intriguing platform to engineer 2D
 7 magnetism due to their large variety of transition metal
 8 compositions including Cr and Mn, their magnetic properties
 9 remain largely experimentally unexplored. Only a few experi-
 10 mental reports are available for $Ti_3C_2T_x$ (T_x in MXene formu-
 11 las stands for surface terminations such as =O, -F, -OH,
 12 and -Cl), where Pauli paramagnetic behavior was observed
 13 after chemical treatments.^{19,20} Several density functional
 14 theory (DFT) studies have predicted magnetism in several
 15 Cr-, V-, Mn-, and Hf-based MXenes.^{21–23} Moreover, recent
 16 computational efforts focus on magnetic properties of
 17 $M''_2M'C_2T_x$ ordered double transition metal MXenes, in
 18 which two layers of a transition metal (M'') sandwich a layer
 19 of another transition metal (M') in a MXene 2D flake.^{24,25} For
 20 example, ferromagnetism has been predicted in $Cr_2VC_2T_x$ ²⁶
 21 and $Hf_2VC_2O_2$,²⁷ with a possibility to tune their magnetic
 22 properties by surface modifications, strain, and external
 23 electric field.²⁸ Antiferromagnetism (AFM) has also been
 24 predicted for $Cr_2TiC_2T_x$, where the net spin densities reside
 25 on the Cr atoms, and the local magnetic moments are
 26 ferromagnetically coupled within the same Cr atomic layer
 27 and antiferromagnetically coupled with the adjacent Cr layer
 28 through the Cr-C bonds.²⁶ This spin configuration resembles
 29 a magnetic tunnel junction, where based on this spin align-
 30 ment DFT calculations have predicted an out-of-plane mag-
 31 netoresistance (MR) of up to 400% in $Cr_2TiC_2T_x$,²⁹ similar to
 32 the very large tunneling magnetoresistance recently observed
 33 experimentally in few-layer CrI_3 .¹⁴ Moreover, it has also been
 34 predicted that the magnetic properties of $Cr_2TiC_2T_x$ depend
 35 strongly on the lattice parameters, surface terminations, and
 36 are tunable by external electric field.^{26,30} Despite several
 37 computational efforts, no experimental reports on the mag-
 38 netic properties of the 2D $Cr_2TiC_2T_x$ have been available
 39 before this study.

40 Here, we provide direct experimental evidence of a magnetic
 41 transition at ~ 30 K (T_f) from a local-moment paramagnet to a
 42 state with a collective magnetic response in $Cr_2TiC_2T_x$ MXene,
 43 which is produced by scalable solution-processing under ambi-
 44 ent conditions (Fig. 1). The magnetic transition is evidenced by
 45 a divergence in zero-field-cooled (ZFC) and field-cooled (FC) dc
 46 magnetization and a maximum in the ac susceptibility. The
 47 transition involves spin freezing to a glassy state, as evidenced
 48 by time dependence of the magnetization and frequency depen-
 49 dence of the ac susceptibility. Evidence for a local but not long-
 50 range magnetic ground state is inferred from the asymmetric
 51 signal observed at the Cr L-edge using temperature-dependent
 52 X-ray linear dichroism measurements. We also show that the
 53 electronic transport in this MXene is strongly coupled with the
 54 magnetic behavior using field- and angular-dependent magne-
 55 toresistance measurements. A large negative linear magnetore-
 56 sistance and a change of angular-dependent magnetoresistance

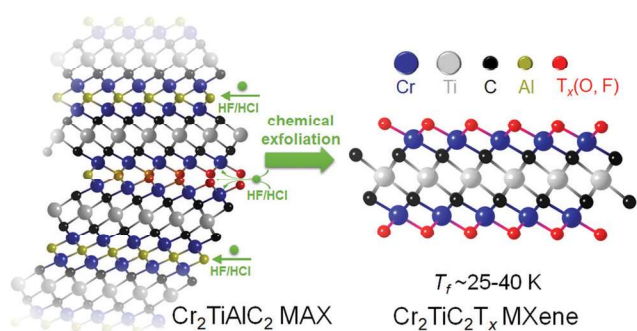


Fig. 1 Synthesis and exfoliation of $Cr_2TiC_2T_x$ MXene. $Cr_2TiC_2T_x$ MXene was synthesized by selective etching of the Al layers from the Cr_2TiAlC_2 MAX phase in a mixture of hydrofluoric (HF) and hydrochloric acids (HCl). The resulting multilayer MXene particles were delaminated into atomically thin flakes using tetramethylammonium hydroxide (TMAOH).

behavior were observed below T_f , illustrating that intrinsic magnetism can indeed bring new functionalities to MXenes.

Experimental section

Synthesis of Cr_2TiAlC_2 MAX

Cr_2TiAlC_2 was synthesized by mixing Cr, Ti, Al and graphite powders (all from Alfa Aesar, Ward Hill, MA), with mesh sizes of -325 , -325 , -325 and -300 , respectively. The molar ratio of Cr:Ti:Al:C was 2:1:1.1:2. The mixture was ball-milled for 18 h using zirconia milling balls in plastic jars. The powder mixture was placed in an alumina crucible and heated at 5°C min^{-1} to 1500°C and held for 1 h under flowing argon. After cooling, the slightly sintered porous compacts were milled into a fine powder using a TiN-coated milling bit. The resulting powder was washed in 9 M HCl acid overnight and sieved through a 400-mesh, producing a powder with a particle size of $< 38\ \mu\text{m}$.

Synthesis of $Cr_2TiC_2T_x$ MXene

Typically, 2 g of the Cr_2TiAlC_2 MAX powder was etched in a mixture of HF (48–51%, Acros Organics), HCl (37%, Fisher Chemical), and deionized (DI) H_2O with a ratio of 6:9:15 mL. The reaction mixture was stirred at 35°C for 42 h. Then the reaction mixture was washed with DI water *via* repeated centrifugation to bring the pH close to neutral. After the washing process, the mixture was filtered on a polypropylene membrane (3501 Coated PP, Celgard LLC Co.) to collect multi-layered (ML-) $Cr_2TiC_2T_x$ MXene. Additional 200 mL of DI water was used to rinse the powder on top of the filtration setup. To delaminate the $Cr_2TiC_2T_x$ MXene, the ML-powder was added to a mixture of 1:9 mL of tetramethylammonium hydroxide (TMAOH, 25% in water, Sigma): DI water. The mixture was stirred overnight at room temperature. After that, the mixture was washed with DI water and centrifuged at 10 000 rpm (12 850 rcf) 4–5 times (50 mL of DI water per wash cycle). The reaction mixture was then probe-sonicated (Fisher Scientific model 505 Sonic Dismembrator, 500 W) for 30 min with a 4 s on alternated with 4 s off pulse. The temperature of the vial was kept at -9°C

1 and argon gas was bubbled through the vial during the sonication process to prevent oxidation of MXene. Finally, the mixture was collected by centrifugation at 3500 rpm for 1 h. The supernatant containing mono- to few-layer flakes of delaminated (d-) $\text{Cr}_2\text{TiC}_2\text{T}_x$ was used for the studies. Note that although centrifugation at 3500 rpm for 1 h has been shown to sufficiently separate mono- to few-layer MXene flakes from other reaction by-products, there might still be a possibility of having nanoparticle by-products that do not sediment after centrifugation. However, we did not observe any nanoparticles in the final d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ solution used in our studies.

Free-standing films of MXene were produced by vacuum-assisted filtration of ~ 20 mL of the d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ solution with a concentration around 1 mg mL^{-1} over a Celgard membrane. Once all the water was removed from the film, it was further dried in a vacuum oven at room temperature. Prolonged exposure of the film to ambient environment might lead to degradation, which may alter magnetic and electronic properties of the MXene. For annealing, the films were placed on an alumina crucible and heated either to 150°C in a vacuum oven or to 500°C in a quartz furnace at $10^\circ\text{C min}^{-1}$ under 100 mL min^{-1} flow of Ar. The samples were held at the designated annealing temperature for 3 h before cooling down naturally. All processes were done using non-magnetizable labware to ensure that there is no magnetic contamination.

Materials characterizations

AFM images were obtained using a Bruker AFM Multimode 8 with a standard tapping mode in air. Driving frequency of 299 kHz, driving amplitude of 17 mV, and scanning frequency of 0.3 Hz were used for the measurement. d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ solution was spin-casted on a Si/SiO₂ substrate and dried under vacuum before the measurement. SEM images were obtained using a Zeiss Supra 50VP electron microscope operated at 5 kV. EDX spectra was collected using Oxford Inca X-Sight, U.K. attached to the SEM. The spectra were collected on 4 spots of the same sample and the average values are reported. XRD patterns were recorded using MiniFlex X-ray diffractometers using Cu K α radiation operated at 40 kV and 15 mA. XPS spectra were collected using a Physical Electronics, Versa Probe 5000 spectrometer with a monochromatic Al K α X-ray source. Charge neutralization was performed using a dual-beam charge neutralizer. High-resolution spectra were collected at a pass energy of 23.5 eV with a step size of 0.05 eV. The peak fitting of the core-level spectra was performed using Casa XPS software package with Shirley-type background. TGA-MS measurement was done using a Discovery SDT 650 thermal balance connected to a Discovery mass spectrometer (TA Instruments, DE). The freestanding MXene films with a mass of ~ 10 mg were dried in a vacuum desiccator at room temperature, packed in a 90 μL alumina pan, and heated to 1500°C at a heating rate of $10^\circ\text{C min}^{-1}$ in He atmosphere (100 mL min^{-1}). The furnace was purged with He gas (100 mL min^{-1}) for 1 h prior to the experiment. HAADF-STEM images and EELS elemental maps were obtained on an ARM-200CF (JEOL, Tokyo, Japan) operating at 200–300 kV and equipped with double spherical

aberration correctors. The resolution of the probe, defined by the objective pre-field, was 78 pm. The $\text{Cr}_2\text{TiC}_2\text{T}_x$ and $\text{Cr}_2\text{TiAlC}_2$ samples for STEM analysis were prepared by drop-casting methods on the TEM grids.

Resistivity and magnetotransport measurements were performed using a Quantum Design EverCool II Physical Property Measurement System (PPMS). For the ρ vs. T measurement, MXene free-standing films dried at room temperature, 150°C , or 500°C were wired to a PPMS puck in a 4-point configuration using silver wire and silver paint. The film thicknesses were measured by an electronic micrometer (MDH-25M, Mitutoyo, IL). For MR measurements, the external magnetic field of up to 90 kOe was applied perpendicularly to the sample surface and was swept at 50 Oe s^{-1} . Dc and ac magnetization measurements were performed on free-standing films (unless otherwise stated) in a Quantum Design MPMS3 (SQUID magnetometry), while vibrating sample magnetometry (VSM) measurements were performed in a Quantum Design PPMS. The Curie-Weiss equation, $\chi_m = C/(T - \theta)$, was used to model the magnetometry data above T_b , where χ_m is the molar magnetic susceptibility (emu per Oe mol Cr), C is the Curie constant (emu K per Oe mol Cr), and θ is the Weiss constant (K) and T is temperature (K). The effective magnetic moment (μ_{eff}) is calculated from the Curie constant using $\mu_{\text{eff}} = (3k_B C/N_A)^{0.5}$, where k_B and N_A are the Boltzmann constant ($1.38 \times 10^{-23} \text{ J K}^{-1}$) and Avogadro number ($6.02 \times 10^{23} \text{ atom per mol}$), respectively. The angular-dependent magnetoresistance of the $\text{Cr}_2\text{TiC}_2\text{T}_x$ and $\text{Ti}_3\text{C}_2\text{T}_x$ MXenes were measured with a horizontal rotator (Quantum Design) with 4-point and van der Pauw contact configurations. The samples were brought to the desired temperatures for measurement and were allowed to reach thermal equilibrium for at least 15 min. The samples were rotated at 1° s^{-1} from 0° to 360° for at least 3 cycles. The data shown in Fig. 4d was smoothed for clarity. The raw data is shown in Fig. S14 (ESI[†]). Synchrotron characterization was done using photoemission electron microscopy (PEEM) and X-ray magnetic linear dichroism (XMLD). $\text{Cr}_2\text{TiC}_2\text{T}_x$ flakes were deposited on p-Si substrates from d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ solution by spin-coating at 1000 rpm for 2 min and 3000 rpm for 15 s. PEEM measurements were performed at the PEEM3 endstation, beamline 11.0.1 of the Advanced Light Source. Total energy resolution was better than 300 meV. X-ray spectroscopy measurements were performed at beamline 4.0.2 of the Advanced Light Source, with energy resolution better than 150 meV. Photon energies were scanned over the Cr L-edge using s- and p-polarized light in a grazing incidence geometry of 30° . The difference between the s- and p-polarization intensity is due to the X-ray linear dichroism effect, which stems from both structural and magnetic origins.

Results and discussion

We begin by discussing the structural and chemical characterization of the MAX and MXene samples used in this study. Aberration-corrected cross-section high-angle annular dark-field scanning transmission electron microscope (HAADF-

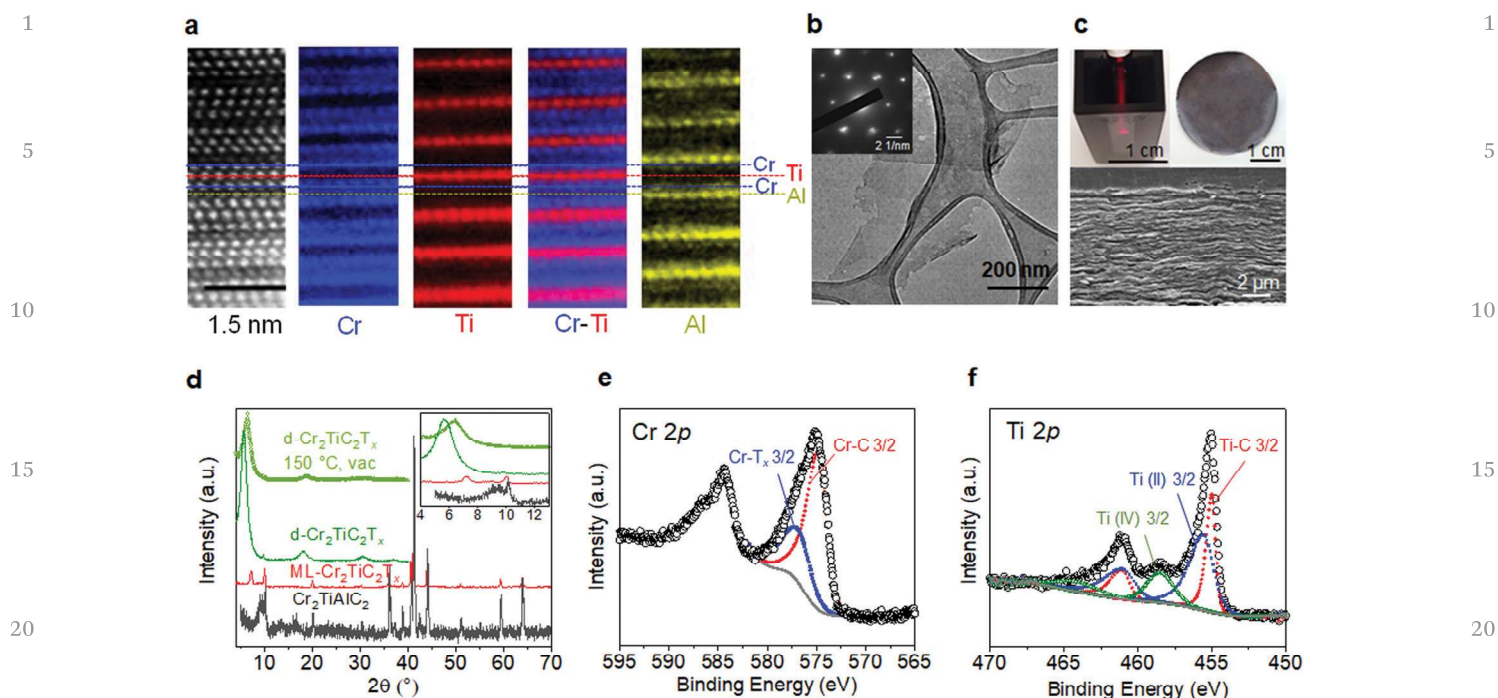


Fig. 2 Structural and chemical characterization of $\text{Cr}_2\text{TiAlC}_2$ MAX phase and $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene. (a) Aberration-corrected high-angle annular dark-field scanning transmission electron micrograph and atomic-resolution electron energy loss spectroscopy of $\text{Cr}_2\text{TiAlC}_2$, indicating that Cr and Ti atoms preferentially occupy the outer and the middle transition metal layers, respectively. (b) Plan-view transmission electron micrograph of 2D $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene. Inset shows selected-area electron diffraction of the flake. (c) Top left: Optical image of delaminated $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene colloidal solution. Top right: Optical image of a free-standing film made by vacuum-assisted filtration of the delaminated solution. Bottom: Scanning electron micrograph of the cross-section of the film. (d) XRD patterns of $\text{Cr}_2\text{TiAlC}_2$ MAX (black), multilayered $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene (red), and delaminated $\text{Cr}_2\text{TiC}_2\text{T}_x$ (green). Inset shows a zoom-in between $2\theta = 4\text{--}13^\circ$. (e) and (f) Core level XPS spectra of (f) Cr 2p and (g) Ti 2p regions.

STEM) and atomic-resolution electron energy loss spectroscopy (EELS) mapping of the $\text{Cr}_2\text{TiAlC}_2$ MAX phase shown in Fig. 2a reveal that Cr preferentially occupies the outer transition metal layer, whereas Ti resides in the middle transition metal layer. This is in good agreement with neutron diffraction and density functional theory (DFT) studies reported previously.^{31,32} Cross-section transmission electron microscope (TEM) image shown in Fig. S1a, ESI† shows a high quality crystal in a large area without visible atomic defects. Successful conversion of MAX to MXene by selective etching of Al layers and delamination (see Experimental section) is evidenced in the plan-view TEM image (Fig. 2b and Fig. S2, ESI†) and selected-area electron diffraction (SAED, inset of Fig. 2b), showing an atomically thin single crystal $\text{Cr}_2\text{TiC}_2\text{T}_x$ flake with a lateral size around 200–1000 nm, in agreement with the atomic force microscopy image shown in Fig. S1b (ESI†). The delaminated $\text{Cr}_2\text{TiC}_2\text{T}_x$ ($\text{d-Cr}_2\text{TiC}_2\text{T}_x$) solution forms a stable colloidal solution in water, and free-standing films with a thickness of up to 10 μm can be produced by vacuum-assisted filtration of the solution as shown in Fig. 2c.

Although conversion of MAX to MXene with this etching condition was incomplete as revealed by the remaining 002 peak of the MAX phase (at $2\theta \sim 10^\circ$) in the X-ray diffraction (XRD) patterns shown in Fig. 2d, delamination and further processing steps (see Experimental section) were employed to ensure that only atomically thin flakes of $\text{d-Cr}_2\text{TiC}_2\text{T}_x$ MXene are present in the samples used for magnetic and electrical measurements. A free-standing film

sample shows a sharp 002 peak at 5.7° , corresponding to interlayer spacing of 15.5 \AA . The peak shifts to 6.4° (13.8 \AA) after vacuum drying at 150 $^\circ\text{C}$ due to loss of intercalated water and adsorbed molecules, as observed in other MXenes.^{33,34} No other impurity such as oxides or carbides was observed in the XRD patterns of the MXene samples after processing (Fig. 2d and Fig. S1e, ESI†). The absence of oxide nanoparticles was also confirmed by large-area TEM images and SAED pattern shown in Fig. S2 (ESI†).

X-ray photoelectron spectroscopy (XPS) was used to determine atomic ratios of the transition metals as well as to provide insights into their bonding environments. XPS spectrum of the Cr 2p_{3/2} (Fig. 2e) can be deconvoluted into two peaks centered at 574.8 eV and 576.8 eV, which are assigned to Cr–C and Cr–T_x bonds, respectively. Although the binding energy of Cr–T_x is in the same range as that of chromium oxides and hydroxides, it can be attributed mainly to the chromium bonded to the oxygen and fluorine surface terminations of MXene since a significant concentration of chromium oxides were not detected in XRD patterns or SAED analysis (see Fig. S1, S2 and Table S1, ESI†). Moreover, Cr₂O₃ typically exhibits multiplet peaks at higher binding energies, which were not observed in our samples. For the Ti 2p region (Fig. 2f), the spectrum was fitted by 3 sets of doublets centered at 455.0 eV (461.1 eV), 455.5 eV (461.6 eV), and 458.5 eV (464.1 eV), which correspond to Ti–C, Ti(II), and Ti(IV), respectively (the binding energies in parentheses correspond to Ti 2p_{1/2}).

1 To study the magnetic properties of the $\text{Cr}_2\text{TiC}_2\text{T}_x$, macroscopic quantities (tens of milligrams) of d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene were synthesized and processed into a textured, free-standing paper (Fig. 2c). The magnetic properties measured from this
5 film morphology inevitably include flake-to-flake coupling, which may affect the macroscopic signal obtained from the magnetometer. The primary characterization was completed by applying the magnetic field (H) within the plane of the sample, which is perpendicular to the c -axis of $\text{Cr}_2\text{TiC}_2\text{T}_x$, assuming the papers are perfectly textured. The results are summarized in Fig. 3. In Fig. 3a, magnetization data obtained above 50 K from the MXene are compared to the full temperature-dependence of the parent MAX phase ($\text{Cr}_2\text{TiAlC}_2$); these results demonstrate that solution-based exfoliation to $\text{Cr}_2\text{TiC}_2\text{T}_x$ greatly enhances the magnetization. Above 100 K, the $\text{Cr}_2\text{TiC}_2\text{T}_x$ sample shows a local-moment paramagnetic response that can be well-described using the Curie–Weiss model. For $H = 10$ kOe, fitting the data between 100 and 350 K yields an effective moment of $2.73 \mu_{\text{B}}$ per Cr atom and a Weiss temperature (θ) of -30.3 K (red line Fig. 3a). The effective moment is slightly reduced from that expected for Cr^{3+} ($3.86 \mu_{\text{B}}$ per Cr atom) but is fairly similar to that predicted by DFT for this MXene ($\sim 2.6 \mu_{\text{B}}$ per Cr atom).²⁶ The negative Weiss temperature indicates dominant antiferromagnetic interactions. The parent MAX phase shows only Pauli paramagnetic behavior, where the magnetization is relatively independent of temperature and much smaller than in the

exfoliated material. This suggests that conversion of MAX to MXene produces a local moment on Cr in $\text{Cr}_2\text{TiC}_2\text{T}_x$ and illustrates that residuals of the MAX phase cannot account for the observed magnetic transition.

The magnetic transition at $T_f \sim 30$ K in $\text{Cr}_2\text{TiC}_2\text{T}_x$ is evidenced through a bifurcation of the zero-field-cooled (ZFC) and field-cooled (FC) dc magnetization (Fig. 3b and Fig. S4, ESI†) as well as by a maximum in the ac susceptibility (Fig. 3c). The in-phase component χ' of the ac susceptibility is shown in Fig. 3c and the small out-of-phase contribution is shown in Fig. S5 (ESI†). χ' has a slight frequency dependence, suggesting a spin freezing transition to a glassy state. Consistent with this, we found that the bifurcation of the ZFC-FC dc magnetization data is decreased as the applied field increases (Fig. S4a, ESI†). The isothermal magnetizations $M(H)$ are shown in Fig. 3d and e. The small and linear $M(H)$ observed for $\text{Cr}_2\text{TiAlC}_2$ is expected for this Pauli paramagnetic phase, while the MXene sample has a much larger induced magnetization with strong curvature in $M(H)$ at 5 K (Fig. 3d). Close inspection reveals a remanence (non-zero moment at $H = 0$) after decreasing the field from 60 kOe. However, this data does not imply ferromagnetic behavior because the net moment is small relative to the effective moment and a time-dependent decay of the remanent magnetization is observed, as shown in Fig. 3f. Similarly, a slow increase in magnetization is observed at 10 K upon applying a magnetic field following an initial zero-field-cooled (Fig. S4b,

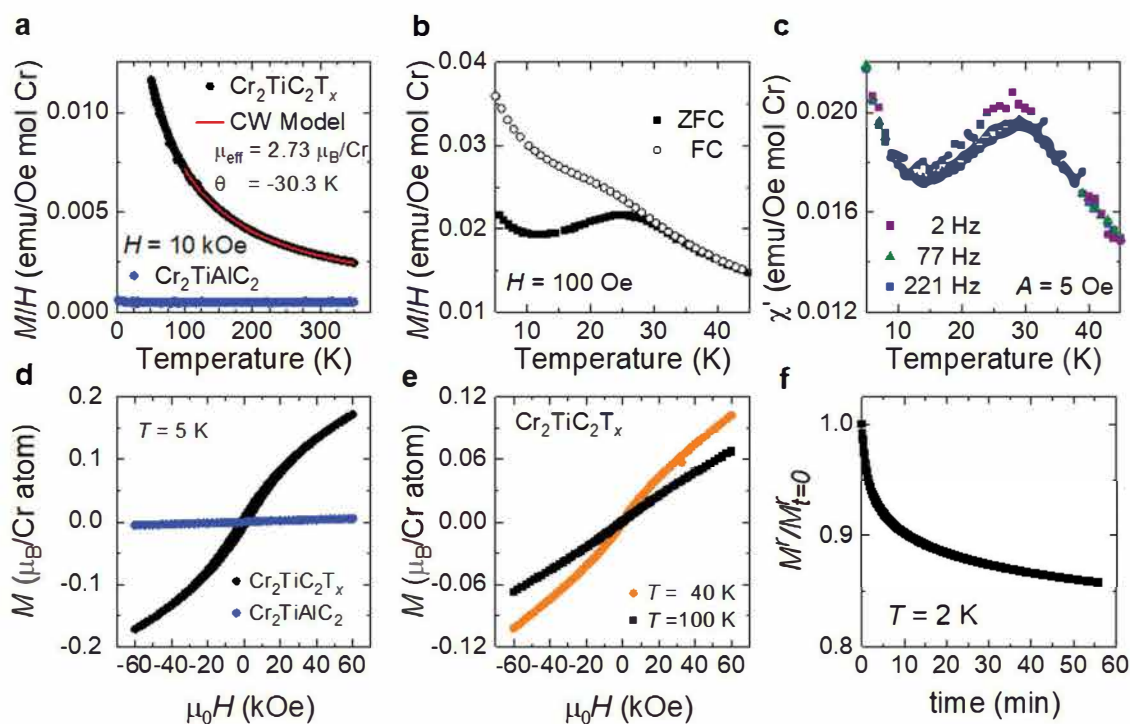


Fig. 3 Magnetic characterization of $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene and $\text{Cr}_2\text{TiAlC}_2$ MAX phase. (a) Field-cooled (FC) magnetization of $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene (black) and $\text{Cr}_2\text{TiAlC}_2$ MAX phase (blue) measured using 10 kOe external magnetic field. The data from $\text{Cr}_2\text{TiC}_2\text{T}_x$ was fitted with Curie–Weiss (CW) model. (b) Zero-field-cooled (filled squares) and field-cooled (empty circles) magnetization from 5–45 K of $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene. (c) In-phase component of ac susceptibility measured at zero dc field with an amplitude of 5 Oe and frequencies ranging from 2–221 Hz. (d) Field-dependent magnetization of $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene (black) and $\text{Cr}_2\text{TiAlC}_2$ MAX phase (blue) measured at 5 K. (e) Field-dependent magnetization of $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene measured at 40 K (orange) and 100 K (black). (f) Time-dependent magnetization measured after cooling $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene from 300 K to 2 K in 60 kOe external field.

1 ESI†). All of these features are consistent with $T_f \sim 30$ K being a spin freezing transition to a state with glassy spin dynamics.

2 The curvature in $M(H)$ at 40 K illustrated in Fig. 3e suggests the strong development of short-range correlations above T_f ,
3 and a slight curvature in $M(H)$ can be inferred at even 100 K. This can be common in materials undergoing a spin freezing
4 transition when the local interactions are strong but intrinsic disorder prevents long-range magnetic order.³⁵ First principles
5 calculations of $\text{Cr}_2\text{TiC}_2\text{T}_x$ found that the ground state spin structure depends on T_x with two distinct antiferromagnetic
6 configurations favored for $-\text{F}$ and $-\text{OH}$ terminations and either ferromagnetic or no magnetic order favored for $=\text{O}$
7 terminations.²⁶ Thus, the inhomogeneous nature of the surface species inherent to MXenes likely inhibits long-range magnetic
8 order, resulting in a glassy state. Moreover, the magnetic disorder could arise from the flake-to-flake coupling of the
9 randomly oriented flakes inevitably present in the sample studied. Note that a more detailed understanding of the
10 magnetic interactions of this MXene could, in theory, be obtained from measurements on a single flake, however such
11 measurements are challenging given the small magnetization values observed even on free-standing film comprising milligrams
12 of the MXene flakes. At 300 K, both the MAX phase and the MXene show linear $M(H)$, consistent with paramagnetic
13 behavior, as shown in Fig. S6 (ESI†). Magnetization measurements with the applied field perpendicular to the plane of the
14 film were also performed. The magnetic response was found to be somewhat anisotropic, further supporting a bulk phase
15 transition. However, the qualitative $M(T)$ and $M(H)$ are similar for both orientations (see Fig. S5, ESI†). Finally, we note that a
16 Curie tail is observed in the MXene below 10 K, indicating that not all moments are frozen below T_f . Subtraction of this
17 contribution to the magnetization, modeled using a Curie-Weiss fit, yields ZFC-FC magnetometry data that is consistent
18 with that typically reported for glassy systems with a nearly temperature-independent FC magnetization and a decreasing
19 ZFC magnetization with decreasing temperature below T_f (Fig. S5f, ESI†).^{36,37}

20 While previous reports of Cr_2O_3 nanoparticle have observed a ZFC-FC divergence,^{38,39} we do not find any evidence of an
21 oxide secondary phase in the MXene samples as described earlier (Fig. 2 and Fig. S1, S2, ESI†), although the absolute
22 absence of a secondary phase can never be completely ruled out. Moreover, the effective moment obtained from the Curie-
23 Weiss fit (Fig. 3a) was calculated based on the mass of $\text{Cr}_2\text{TiC}_2\text{T}_x$ and the value would have been different by orders
24 of magnitude if the measured magnetization signal was dominated by oxide nanoparticles. We further note that ZFC-FC
25 measurements performed on $\text{Cr}_2\text{TiC}_2\text{T}_x$ multilayer powder and several free-standing films ($\text{d-Cr}_2\text{TiC}_2\text{T}_x$) reproducibly
26 yielded the cusp in the ZFC data within a temperature range from 22 to 27 K for the as-synthesized films and the film
27 annealed at 150 °C, while that of the film annealed at 500 °C was found at 40 K, as shown in Fig. S7 (ESI†). The presence of
28 the magnetic transition in $\text{Cr}_2\text{TiC}_2\text{T}_x$ regardless of the sample preparation or post-synthesis treatments, and the lack of a

29 magnetic transition in the parent MAX powder that often contains secondary Cr-based phases including chromium oxides,
30 further points to the MXene as the origin of the magnetic response.³¹ The difference in the transition temperature
31 observed could possibly be due to the difference in surface terminations between different batches of MXene synthesized
32 and surface modification by thermal annealing, which warrants further studies. Moreover, the difference in the flake-to-flake
33 stacking, and thus flake-to-flake coupling and local magnetic interactions, between different samples could also play a role in
34 the variation in the transition temperature and the broad peak in the ZFC curves.

35 To further investigate the magnetic properties of the free-standing film ($\text{d-Cr}_2\text{TiC}_2\text{T}_x$), we performed X-ray absorption
36 (XA) spectroscopy with orthogonal orientations of linearly polarized X-ray across the Cr L-edge in the temperature range
37 of 12–300 K (Fig. S8a, ESI†). X-ray linear dichroism (XLD) measures anisotropy in the electronic structure of the Cr
38 species, due to the polarization dependence of the XA measurements. The XLD signal is quite strong (peak intensity $\sim 5\%$)
39 and robust across the entire range of measured temperatures. In general, this XLD signal could originate both from an in-
40 plane vs. out-of-plane structural anisotropy and from magnetic ordering. We attribute the temperature-independent XLD signal
41 here to structural anisotropy rather than magnetic order because temperature will only weakly affect the structural
42 asymmetry of the MXene in the absence of a structural phase transition. This result highlights the highly 2D nature of the
43 layered MXene structure that is present even in the macroscopic free-standing films, which we also demonstrated by an
44 agreement with XA and XLD measurements of $\text{Cr}_2\text{TiC}_2\text{T}_x$ flakes dispersed on the Si substrate (Fig. S8b, ESI†). The lack of a
45 magnetic contribution to the XLD signal can be explained by the disordered magnetic moments in a relaxed spin glass below
46 the transition temperature T_f and paramagnetic behavior above T_f , in agreement with the magnetometry results. To rule out
47 extrinsic magnetic disorder arising from in-plane rotations of the MXene grains within the film and randomly dispersed
48 MXene flakes, we measured spatially resolved XA spectra of individual flakes using soft X-ray photoemission electron
49 microscopy (PEEM), as shown in Fig. S8c and d (ESI†). XA and XLD spectra localized to a single $\text{Cr}_2\text{TiC}_2\text{T}_x$ flake agree
50 qualitatively with the spatially-averaged XA findings from the film. We note that the spectral features of our measured data
51 are distinctly different from that of Cr_2O_3 and CrO_2 , further supporting the absence of such nanoparticles, which were not
52 observed even within chemical imaging capabilities of PEEM measurements (Fig. S8, ESI†).^{40,41}

53 Electronic transport measurements provide additional evidence that a magnetic transition is present in the MXene. As
54 previously detailed, the presence of intercalants and surface termination lead to significant increases in resistivity (ρ) when
55 probed *via* macroscopic transport measurements.⁴² For this study, we performed *in situ* annealing of the $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene
56 in vacuum up to 700 °C, where more than two orders of magnitude decrease in resistivity was observed as described

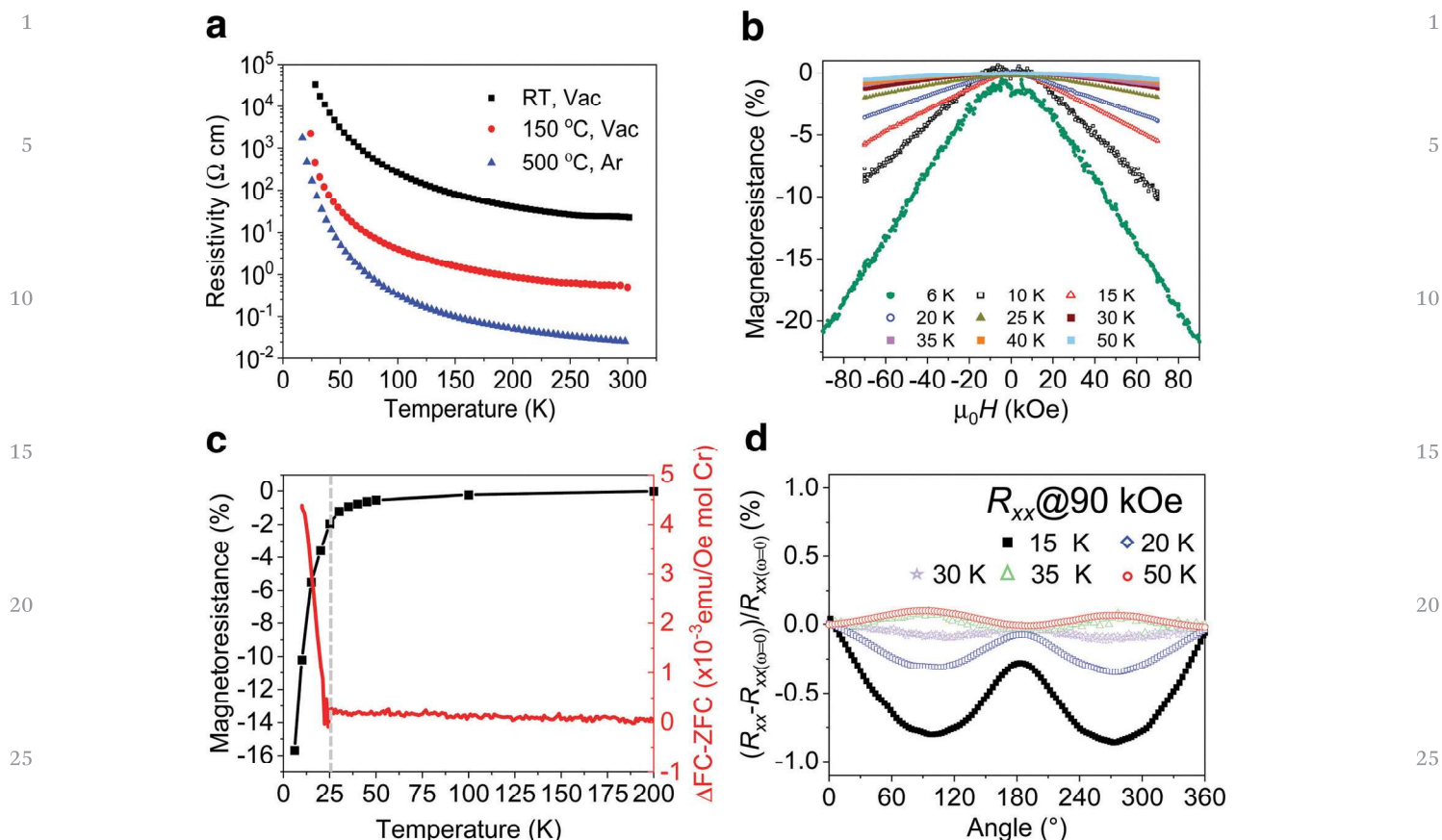


Fig. 4 Magnetotransport measurements. (a) Temperature-dependent resistivity of free-standing films dried at room temperature (black), 150 °C (red), and 500 °C (blue). (b) Field-dependent magnetoresistance of the free-standing film annealed at 150 °C from 6 to 50 K. (c) A comparison between magnitude of magnetoresistance measured at 70 kOe (left axis) and the difference between the field-cooled and zero-field-cooled magnetization (right axis). (d) Angular-dependent longitudinal magnetoresistance (R_{xx}) measured at 90 kOe from 15 to 50 K.

in Fig. S9 (ESI[†]). As suggested by TGA-MS data (Fig. S1e, ESI[†]), the predominant decrease in resistivity can be attributed to decomposition of TMA⁺ ions below 500 °C. Therefore, for the low-temperature magnetoresistance measurements, we annealed the d-Cr₂TiC₂T_x MXene free-standing films at either 150 °C or 500 °C to decrease electrical resistivity and improve the precision of the measurements. As shown in Fig. 4a, the magnitude of the resistivity decreases significantly after these anneals, but the slope of temperature-dependent resistivity ($d\rho/dT$) remains negative, consistent with the *in situ* annealing experiment (Fig. S9, ESI[†]). Cr₂TiC₂T_x shows some of the strongest dependence of resistivity on temperature for MXenes reported so far, where the resistivity increases by a few orders of magnitude upon cooling the samples below 50 K.¹⁵ A sharp increase in the junction resistance was also observed in CrI₃ tunnel junction device with a kink near the magnetic transition temperature, which is caused by different barrier heights experienced by electrons with opposite spins.⁴³ Although we did not observe any anomaly in the temperature-dependence of resistivity, a clear inflection point in the reduced activation energy analysis is observed near 30 K, suggesting a coupling between the electronic transport and magnetic state of the MXene (Fig. S11, ESI[†]). Note that our macroscopic transport

measurement on the MXene free-standing films, comprise stacked of many 2D flakes, may be the reason for low sensitivity of resistive detection of the magnetic transition temperature. Importantly, the ZFC-FC divergence is maintained even after the 500 °C anneal (Fig. S10a, ESI[†]), indicating that this annealing step to decrease resistivity of the films does not significantly alter the magnetic transition.

We investigated the magnetotransport properties of the Cr₂TiC₂T_x MXene by measuring field-dependent (MR) and angular-dependent magnetoresistance (AMR) of a free-standing film (d-Cr₂TiC₂T_x) dried at 150 °C. For the MR experiments, the change in magnetoresistance (%MR) was recorded at various temperatures as the external magnetic field (H) was varied perpendicularly to the sample surface as shown in Fig. 4b. We define %MR as $(\rho_H - \rho_{H=0})/\rho_{H=0} \times 100\%$, where ρ_H and $\rho_{H=0}$ are the resistivities in the presence and absence of H , respectively. Cr₂TiC₂T_x starts to exhibit appreciable MR below 50 K, and its magnitude increases significantly below ~30 K, reaching a negative %MR value of ~20% at 6 K and 90 kOe. This large negative %MR observed in Cr₂TiC₂T_x is much more pronounced compared to non-magnetic MXenes, where %MR has been reported to be less than 5% at comparable magnetic field and temperature.^{44–46} As can be seen in Fig. 4c,

1 the change of the %MR magnitude coincides almost perfectly
with the divergence observed in the ZFC and FC measurements,
pointing to a coupling between magnetic and electronic trans-
port properties. One possible explanation of the negative MR
5 arises from a reduction of spin-dependent scattering of
carriers.⁴⁷ It is very unlikely that impurity oxide particles (if
there are any presence in the sample) are accountable for both
the peak in ZFC curve and the macroscopic magnetotransport
behaviors of the MXene. We note in passing that, in contrast to
10 a classical quadratic magnetoresistance, the MR observed in
 $\text{Cr}_2\text{TiC}_2\text{T}_x$ is linear above ± 20 kOe as shown in Fig. S12 (ESI[†]).
Similar MR behavior was also observed in the sample annealed
at 500 °C (Fig. S10, ESI[†]), suggesting that the magnetotransport
behavior is independent of intercalant and/or surface
15 termination.

Angular-dependent magnetoresistance (AMR) measure-
ments, where the longitudinal resistance (R_{xx}) and Hall resis-
tance (R_{xy}) of a d- $\text{Cr}_2\text{TiC}_2\text{T}_x$ free-standing film are recorded as it
is rotated with respect to H , provide further evidence of the
20 magnetic transition and coupling between magnetic and elec-
tronic transport properties. Here, H is perpendicular (parallel)
to the sample surface at 0° (90°), see Fig. S13, ESI[†] and
Experimental Section. We define the normalized AMR as $(R_{\omega}$
 $- R_{\omega=0})/R_{\omega=0} \times 100\%$, where ω is the angle between the applied
25 field direction and the sample surface; R_{ω} and $R_{\omega=0}$ are the
resistance values measured at ω and 0°, respectively. Shown in
Fig. 4d are normalized R_{xx} of $\text{Cr}_2\text{TiC}_2\text{T}_x$ measured from 15 to
50 K with $H = 90$ kOe. Strikingly, R_{xx} shows a clear difference
between that measured above and below T_f . At 35 and 50 K, R_{xx}
30 exhibits an almost identical functional form analogous to $\sin^2\omega$
with two maxima at around 90° and 270°. However, it changes
to a different functional form with two minima at lower
temperatures and the magnitude of the minima increases with
decreasing temperature. Note that at 35 K and above, the
35 resistance is maximum when H is parallel to the sample surface
(90°), while the opposite is true at 30 K and lower temperatures.
This suggests the presence of an anisotropic magnetoresistance
component, which might stem from anisotropic magnetization
of the $\text{Cr}_2\text{TiC}_2\text{T}_x$ below T_f . Similar changes in the shape of R_{xy}
40 are observed below 30 K, as presented in Fig. S13 (ESI[†]).
Although the magnetotransport property of MXenes is not
well-understood,⁴⁸ this abrupt change of the magnetoresis-
tance at the magnetic transition temperature provides further
evidence of a coupling between magnetic and magnetoelectronic
45 transport of $\text{Cr}_2\text{TiC}_2\text{T}_x$. For comparison, the paramagnetic
 $\text{Ti}_3\text{C}_2\text{T}_x$ MXene shows negligible difference in AMR between 10
and 50 K (Fig. S15, ESI[†]).

50 Conclusions

In summary, we presented clear evidence of a magnetic transi-
tion in 2D $\text{Cr}_2\text{TiC}_2\text{T}_x$ MXene at ~ 30 K, which was not observed
in its $\text{Cr}_2\text{TiAlC}_2$ MAX precursor. Magnetometry reveals a clear
55 bifurcation in the macroscopic magnetization as measured
under ZFC and FC conditions, along with the presence of glassy

dynamics in the low-temperature state. The divergence of the
ZFC-FC magnetization is accompanied by a significant increase
in magnetoresistance that is negative, linear and non-
saturating up to 90 kOe below T_f . The demonstration of a
magnetic transition in the $\text{Cr}_2\text{TiC}_2\text{T}_x$ demonstrates the feasi-
5 bility of MXenes to host magnetic interactions and lays the
groundwork for future studies of magnetism in this relatively
new and rapidly growing family of 2D transition metal carbides
and nitrides.

Conflicts of interest

Q4

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